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CITATION
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PATENT DOCUMENTS

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		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
UD		8-274411	10/18/96	JAPAN				
		8-116090	05/07/96	JAPAN				
		5-283744	10/29/93	JAPAN				
		4-303920	10/27/92	JAPAN				
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Partial Translation of Japanese Patent Application No. 9-311518 dated June 10, 2003.

D. Kaponnek et al. "Anisotropic epitaxial lateral growth in GaN selective area epitaxy", Appl. Phys. Lett. 71 (9), September 1, 1997, pp. 1204-1206.

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Applicant(s)

Norikatsu Koide

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Yoshinori Ujile et al., "Epitaxial Lateral Overgrowth of GaAs on a Si Substrate", Japanese Journal of Applied Physics, Vol. 28, No. 3, March, 1989, pp. L337-L339.

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TJ	6,051,849	04/18/00	Davis et al.			
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	6,355,497 B1	03/12/02	Romano et al.			
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T	6,110,277	08/29/00	Braun			

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						YES	NO
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	2000-150959	05/30/00	JAPAN				
	2000-261106	09/22/00	JAPAN				
	8-64791	03/08/96	JAPAN				
	7-273367	10/20/95	JAPAN				

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TJ	Akasaki et al., "Effects of AlN Buffer Layer on Crystallographic Structure and on Electrical and Optical Properties of GaN and Ga _{1-x} Al _x N...Movie", pp. 209-219, Journal of Crystal Growth 98 (1989) North-Holland, Amsterdam.
TJ	Yang et al., "High Quality GaN-InGaN heterostructures grown on (111) silicon substrates", pp. 3566-3568, Appl. Phys. Lett. 69 (23), December 2, 1996.

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							YES	NO
DB		11-260737	09/24/99	JAPAN				
		11-251632	09/17/99	JAPAN				
		05-041536	02/19/93	JAPAN				
		04-084418	03/17/92	JAPAN				
		EP 0 551 721 A2	11/12/92	EUROPE			✓	

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		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
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77		EP 0 951 055 A2	11/10/98	EUROPE			✓	
		EP 1 059 677 A2	12/13/00	EUROPE			✓	
		EP 1 059 661 A2	12/13/00	EUROPE			✓	
		EP 1 045 431 A1	10/18/00	EUROPE			✓	
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73		PCT Form 210 (PCT/JP02/05446)
76		PCT Form 210 (PCT/JP02/02628)

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INFORMATION DISCLOSURE CITATION <i>(Use several sheets if necessary)</i> 2/15/05		Docket Number (Optional)	Application Number	
		F03-367-US div		Not Yet Assigned
		Applicant(s)		10625025
		Norikatsu Koide		
		Filing Date	Group Art Unit	
		Concurrently Herewith		Not Yet Assigned

*EXAMINER INITIAL	OTHER DOCUMENTS <i>(Including Author, Title, Date, Pertinent Pages, Etc.)</i>
TD	PCT Form 210 (PCT/JP02/01159) ✓
TD	PCT Form 210 (PCT/JP01/01928) ✓
TD	PCT Form 210 (PCT/JP01/02695) ✓
TD	PCT Form 210 (PCT/JP00/09120)
TD	PCT Form 210 (PCT/JP01/01396)
TD	PCT Form 210 (PCT/JP01/01178)
TD	PCT Form 210 (PCT/JP01/01663)
TD	PCT Form 210 (PCT/JP00/09121)
TD	PCT Form 210 (PCT/JP00/09220)
TD	PCT Forms 338 and 409 (IPER) (PCT/JP01/02695) and translations. ✓
TD	PCT Forms 338 and 409 (IPER) (PCT/JP01/01663) and translations
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INFORMATION DISCLOSURE CITATION

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Docket Number (Optional)

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Application Number

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Applicant(s)

Norikatsu Koide

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Wolf et al., "SILICON PROCESSING for the VLSI Era," Vol. 1, Page 5, Lattice Press, 1986.

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						YES	NO
77	5-343741	12/1993	JAPAN				
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		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	YES	NO
TH		11-191657	07/1999	JAPAN				
02		11-191533	07/1999	JAPAN				
TP		57-115849	07/1982	JAPAN				
ly		3-133182	06/1991	JAPAN				

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		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
77		5-110206	04/1993	JAPAN				
1		1-316459	12/1989	JAPAN				
		7-249830	09/1995	JAPAN				
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							YES	NO
TV		10-321954	12/1998	JAPAN				
TV		10-312971	11/1998	JAPAN				
TV		11-145519	05/1999	JAPAN				
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76		Zheleva et al, "Pendeo-Epitaxy - A New Approach for Lateral Growth of Gallium Nitride Structures", MRS Internet J. Nitride Semicond. Res. 4S1, G3.38 (1999).
75		Dimitriadis et al, "Contacts of Titanium Nitride to n- and p-type Gallium Nitride Films", Solid State Electronics Vol. 43, (1999), pp. 1969-1972.

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							YES	NO
TL		11-329971	11/1999	JAPAN				
TL		11-031864	02/1999	JAPAN				
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76		Zheleva et al., "Pendeo-Epitaxy: A New Approach for Lateral Growth of Gallium Nitride Films", Journal of Electronic Materials, Vol. 28, No. 4, (1999), pp. L5-L8.

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500		2000-124500	04/2000	JAPAN				
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		2000-232239	08/2000	JAPAN				
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27			Uchida et al., "AlGaInN Based Laser Diodes", III-Vs Review: Covering Advanced Semiconductors Worldwide, Vol. 13, No. 3, May/June 2000, pp. 156-164.

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							YES	NO
FD		2000-106455	04/2000	JAPAN				
		2000-357843	12/2000	JAPAN				
		2000-091253	03/2000	JAPAN				
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		2001-122693	05/2001	JAPAN				

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		WO 97/11518	03/1997	WIPO				

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